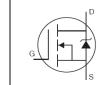


AUIRFR4104 AUIRFU4104

Features

- Advanced Process Technology
- Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



HEXFET[®] Power MOSFET

V _{DSS}	40V
R _{DS(on)} max.	5.5mΩ
ID (Silicon Limited)	119A
ID (Package Limited)	42A

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

		Fee s	D TE	s G ^D
	A	D-Pak UIRFR4104		I-Pak AUIRFU4104
G		D		S
Gate		Drain		Source

Bass part number Daskage Tur		Standard Pack		Orderable Part Number
Base part number	part number Package Type Form		Quantity	Orderable Part Number
AUIRFU4104	I-Pak	Tube	75	AUIRFU4104
	D Dek	Tube	75	AUIRFR4104
AUIRFR4104	D-Pak	Tape and Reel Left	3000	AUIRFR4104TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	119	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	84	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	A
I _{DM}	Pulsed Drain Current ①	480	
P _D @T _C = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.95	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	145	
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value 6	310	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case ®		1.05	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ ext{ heta}JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



AUIRFR/U4104

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	40			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.032		V/°C	Reference to 25°C, I_D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		4.3	5.5	mΩ	V _{GS} = 10V, I _D = 42A ③
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Trans conductance	58			S	V _{DS} = 10V, I _D = 42A ③
1	Drain to Source Leakage Current			20	μA	$V_{DS} = 40V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source Leakage Current			250	μΑ	V _{DS} = 40V,V _{GS} = 0V,T _J =125°C
1	Gate-to-Source Forward Leakage			200	n A	V _{GS} = 20V
I _{GSS}	Gate-to-Source Reverse Leakage			-200		V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q _g	Total Gate Charge		59	89		I _D = 42A		
Q_{gs}	Gate-to-Source Charge		19		nC	V _{DS} = 32V		
Q _{gd}	Gate-to-Drain Charge		24			V _{GS} = 10V③		
t _{d(on)}	Turn-On Delay Time		17			V _{DD} = 20V		
t _r	Rise Time		69		200	I _D = 42A		
t _{d(off)}	Turn-Off Delay Time		37		ns	$R_{G} = 6.8\Omega$		
t _f	Fall Time		36			V _{GS} = 10V③		
L _D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)		
L _S	Internal Source Inductance		7.5		1111	from package and center of die contact		
C _{iss}	Input Capacitance		2950			V _{GS} = 0V		
C _{oss}	Output Capacitance		660			V _{DS} = 25V		
C _{rss}	Reverse Transfer Capacitance		370		pF	<i>f</i> = 1.0MHz		
C _{oss}	Output Capacitance		2130		рі	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$		
C _{oss}	Output Capacitance		590			$V_{GS} = 0V, V_{DS} = 32V f = 1.0MHz$		
C _{oss eff.}	Effective Output Capacitance		850			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V$		
	Diode Characteristics							
	Parameter	Min.	Тур.	Max.	Units	Conditions		
ls	Continuous Source Current (Body Diode)			42		MOSFET symbol showing the		
1	Pulsed Source Current			480	A	integral reverse		

Qrr	Reverse Recovery Charge		24	36	nC	di/dt = 100A/µs③
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by Ls+			ole (turn-on is dominated by $L_{S}+L_{D}$)	

Notes:

I_{SM}

 V_{SD}

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 0.16mH, R_G = 25 Ω , I_{AS} = 42A, V_{GS} =10V. Part not recommended for use above this value.

480

1.3

42

28

V

ns

p-n junction diode.

T_J = 25°C,I_S = 42A, V_{GS} = 0V ③

T_.I = 25°C ,I_F = 42A, V_{DD} = 20V

Pulse width \leq 1.0ms; duty cycle \leq 2%. 3

(Body Diode) ①

Diode Forward Voltage

Reverse Recovery Time

- Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS 4
- Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance. (5)
- This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.16mH, $R_G = 25\Omega$, $I_{AS} = 42A$, $V_{GS} = 10V$. 6
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to \bigcirc application note #AN-994
- 8 R_{θ} is measured at T_J approximately 90°C.



Vgs

TOP

BOTTOM

60µs PULSE WIDTH Tj = 175°C | | | | |

10

15V 10V

8.0V 7.0V 6.0V

5.5V 5.0V 4.5V

100

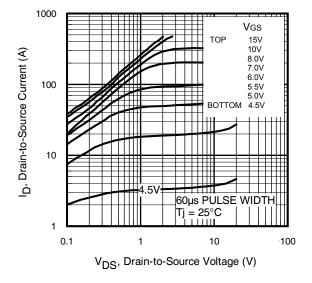


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics

V_{DS}, Drain-to-Source Voltage (V)

1

1000

100

10

1

0.1

I_D, Drain-to-Source Current (A)

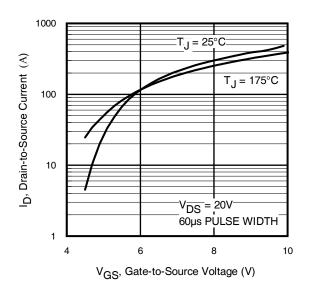


Fig. 3 Typical Transfer Characteristics

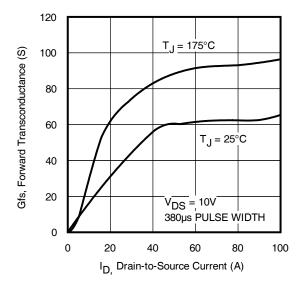
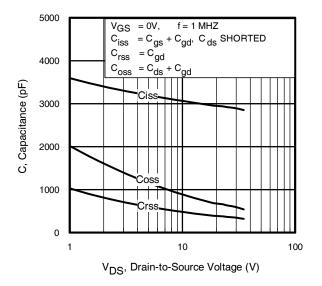
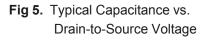


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







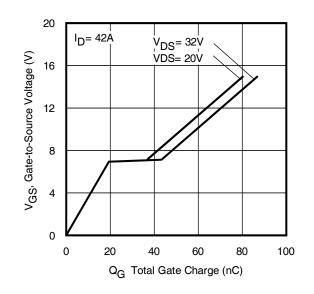
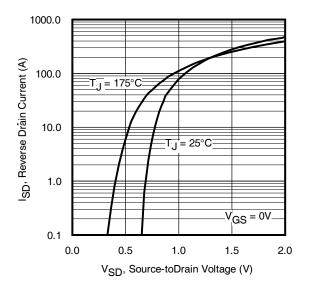


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage





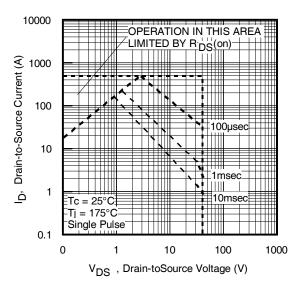


Fig 8. Maximum Safe Operating Area



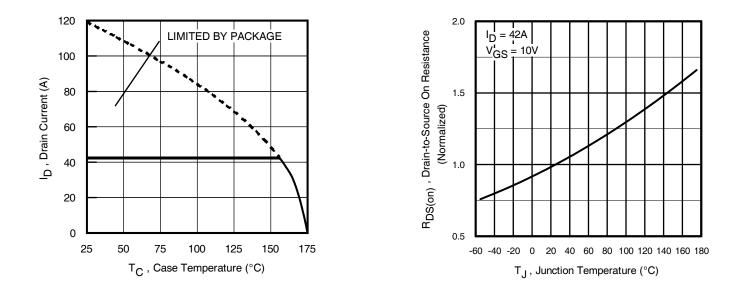
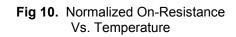


Fig 9. Maximum Drain Current Vs. Case Temperature



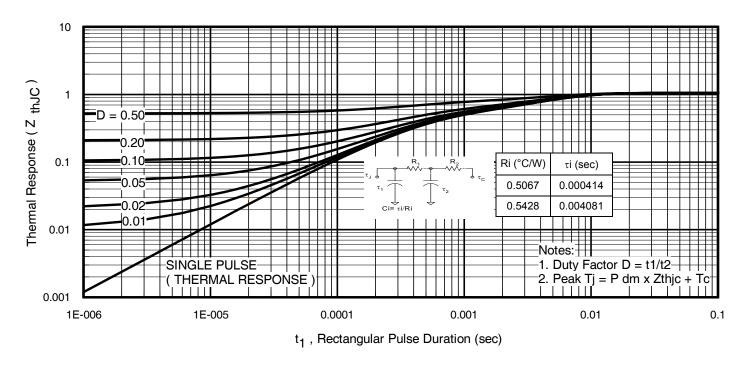


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

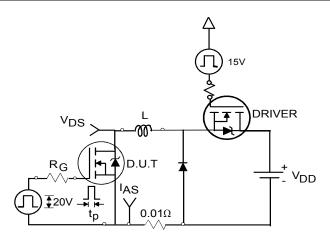


Fig 12a. Unclamped Inductive Test Circuit

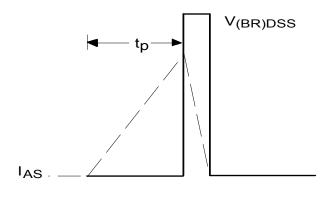


Fig 12b. Unclamped Inductive Waveforms

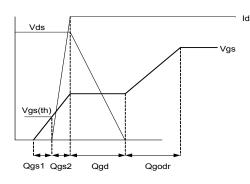


Fig 13a. Gate Charge Waveform

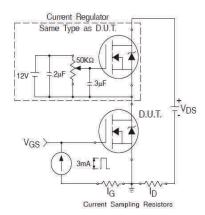
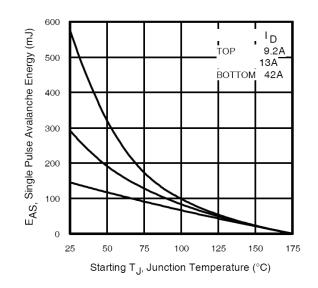
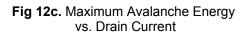


Fig 13b. Gate Charge Test Circuit





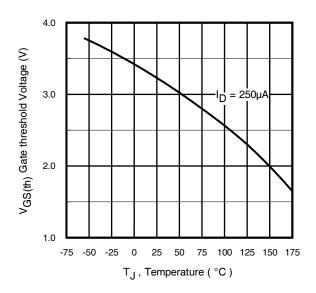


Fig 14. Threshold Voltage Vs. Temperature



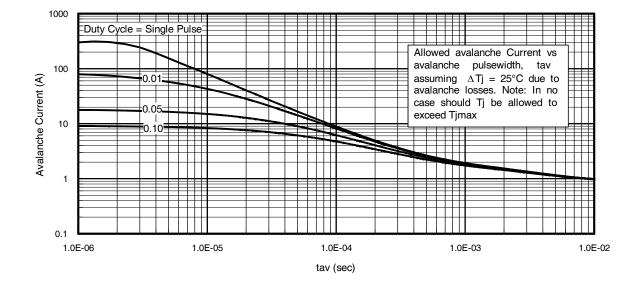
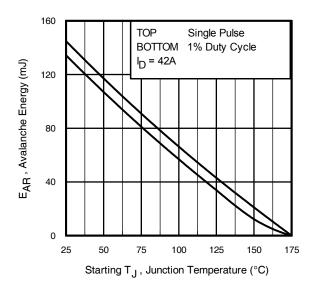
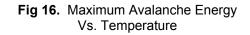


Fig 15. Typical Avalanche Current Vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; \textbf{[} 1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th} \textbf{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



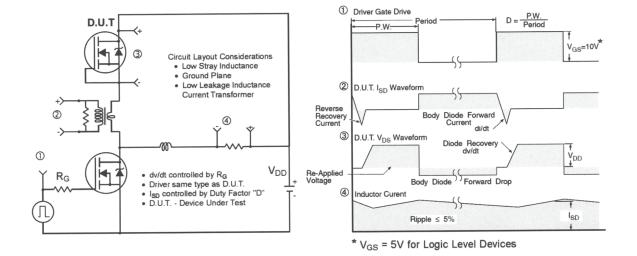
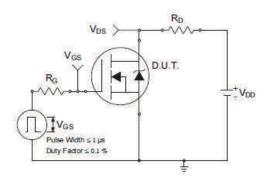
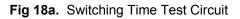


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs





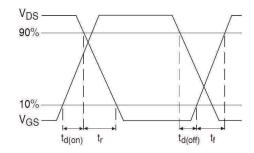
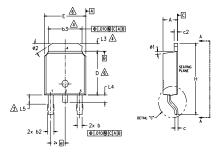


Fig 18b. Switching Time Waveforms

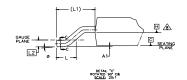


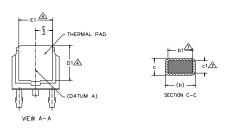
AUIRFR/U4104

D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- A- DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

9	OUTLINE	CONFORMS	TO	JEDEC	OUTLINE	TO-252AA.	

S Y M		DIMENSIONS						
В	MILLIM	ETERS	INC	HES	0 T			
0 L	MIN.	MAX.	MIN.	MAX.	Ê			
А	2.18	2.39	.086	.094				
A1	-	0.13	-	.005				
b	0.64	0.89	.025	.035				
ь1	0.65	0.79	.025	.031	7			
b2	0.76	1.14	.030	.045				
b3	4.95	5.46	.195	.215	4			
с	0.46	0.61	.018	.024				
c1	0.41	0.56	.016	.022	7			
c2	0.46	0.89	.018	.035				
D	5.97	6.22	.235	.245	6			
D1	5.21	-	.205	-	4			
Е	6.35	6.73	.250	.265	6			
E1	4.32	-	.170	-	4			
е	2.29	BSC	.090	BSC				
н	9.40	10.41	.370	.410				
L	1.40	1.78	.055	.070				
L1	2.74	BSC	.108	REF.				
L2	0.51	BSC	.020	BSC				
L3	0.89	1.27	.035	.050	4			
L4	-	1.02	-	.040				
L5	1.14	1.52	.045	.060	3			
ø	0.	10*	0.	10°				
ø1	0.	15 '	0.	15 °				
ø2	25'	35'	25*	35*				

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

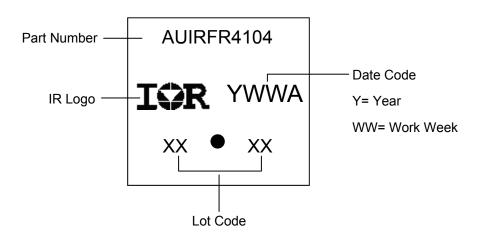
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

4.- COLLECTOR

D-Pak (TO-252AA) Part Marking Information





AUIRFR/U4104

I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)

NOTES:

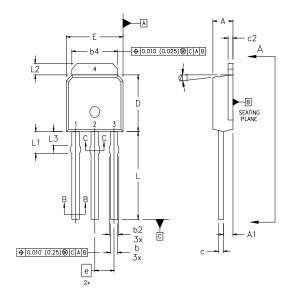
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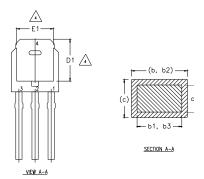
2

3

5 6 /

8





		DIMEN	ISIONS		
SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
A	2.18	2.39	0.086	.094	
A1	0.89	1.14	0.035	0.045	
b	0.64	0.89	0.025	0.035	
ь1	0.64	0.79	0.025	0.031	4
b2	0.76	1.14	0.030	0.045	
b3	0.76	1.04	0.030	0.041	
b4	5.00	5.46	0.195	0.215	4
с	0.46	0.61	0.018	0.024	
c1	0.41	0.56	0.016	0.022	
c2	.046	0.86	0.018	0.035	
D	5.97	6.22	0.235	0.245	3, 4
D1	5.21	-	0.205	-	4
E	6.35	6.73	0.250	0.265	3, 4
E1	4.32	-	0.170	-	4
e	2.	29	0.090) BSC	
L	8.89	9.60	0.350	0.380	
L1	1.91	2.29	0.075	0.090	
L2	0.89	1.27	0.035	0.050	4
L3	1.14	1.52	0.045	0.060	5
ø1	0*	15'	0*	15'	

DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.

LEAD DIMENSION UNCONTROLLED IN L3.

CONTROLLING DIMENSION : INCHES.

DIMENSION 61, 63 APPLY TO BASE METAL ONLY.

OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

DIMENSION ARE SHOWN IN MILLIMETERS [INCHES]. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.

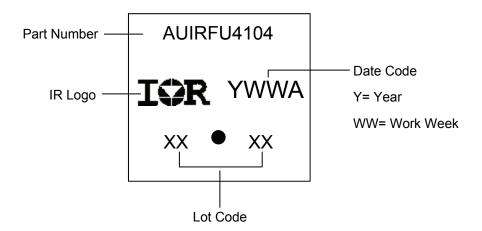
LEAD ASSIGNMENTS

<u>HEXFET</u>

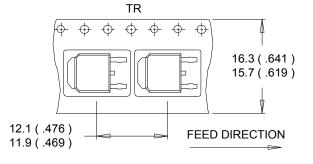
1.- GATE

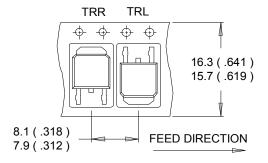
2.- DRAIN 3.- SOURCE 4.- DRAIN

I-Pak (TO-251AA) Part Marking Information



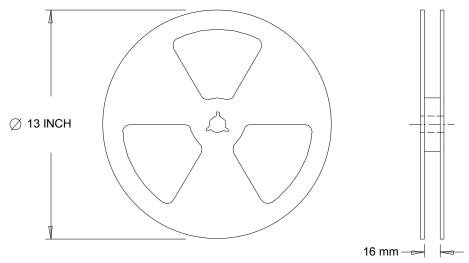
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.



Qualification Information

		Automotive (per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moioturo	Moisture Sensitivity Level		MSL1			
Moisture			WISE I			
			Class M4 (+/- 425V) [†]			
	Machine Model	AEC-Q101-002				
500			Class H1C (+/-1750V) [†]			
ESD	Human Body Model	AEC-Q101-001				
	Objective of Device Martial		Class C5 (+/-625V) [†]			
	Charged Device Model	AEC-Q101-005				
RoHS Cor	RoHS Compliant		Yes			

+ Highest passing voltage.

Revision History

Date	Comments
12/1/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo RthJA (PCB Mount) from "40C/W" to "50C/W" on page 1.
10/05/2017	Corrected typo error on part marking on page 9 and 10.

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